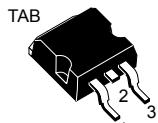
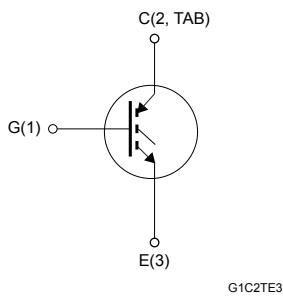


## Trench gate field-stop, 650 V, 50 A, high-speed HB2 series IGBT in a D<sup>2</sup>PAK package

### Features

D<sup>2</sup>PAK

- Maximum junction temperature:  $T_J = 175 \text{ }^{\circ}\text{C}$
- Low  $V_{CE(\text{sat})} = 1.55 \text{ V}(\text{typ.}) @ I_C = 50 \text{ A}$
- Minimized tail current
- Tight parameter distribution
- Low thermal resistance
- Positive  $V_{CE(\text{sat})}$  temperature coefficient



### Applications

- Welding
- PFC converters - single phase input
- Solar inverters (string and central)
- Uninterruptable power supplies (UPS)
- EV charging - DC fast charging stations

### Description

The newest IGBT 650 V HB2 series represents an evolution of the advanced proprietary trench gate field-stop structure. The performance of the HB2 series is optimized in terms of conduction, thanks to a better  $V_{CE(\text{sat})}$  behavior at low current values, as well as in terms of reduced switching energy. The result is a product specifically designed to maximize efficiency for a wide range of fast applications.



#### Product status link

[STGB50H65FB2](#)

#### Product summary

Order code	STGB50H65FB2
Marking	G50H65FB2
Package	D <sup>2</sup> PAK
Packing	Tape and reel

## 1 Electrical ratings

**Table 1. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
V <sub>CES</sub>	Collector-emitter voltage ( $V_{GE} = 0$ V)	650	V
I <sub>C</sub>	Continuous collector current at $T_C = 25$ °C	86	A
	Continuous collector current at $T_C = 100$ °C	53	
I <sub>CP</sub> <sup>(1)(2)</sup>	Pulsed collector current	150	
V <sub>GE</sub>	Gate-emitter voltage	±20	V
	Transient gate-emitter voltage ( $t_p \leq 10$ µs)	±30	
P <sub>TOT</sub>	Total power dissipation at $T_C = 25$ °C	272	W
T <sub>stg</sub>	Storage temperature range	-55 to 150	°C
T <sub>J</sub>	Operating junction temperature range	-55 to 175	

1. Defined by design, not subject to production test.
2. Pulse width is limited by maximum junction temperature.

**Table 2. Thermal data**

Symbol	Parameter	Value	Unit
R <sub>thJC</sub>	Thermal resistance junction-case	0.55	°C/W
R <sub>thJA</sub>	Thermal resistance junction-ambient	50	

## 2 Electrical characteristics

$T_C = 25^\circ\text{C}$  unless otherwise specified

**Table 3. Static characteristics**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(\text{BR})\text{CES}}$	Collector-emitter breakdown voltage	$V_{GE} = 0 \text{ V}, I_C = 1 \text{ mA}$	650			V
$V_{CE(\text{sat})}$	Collector-emitter saturation voltage	$V_{GE} = 15 \text{ V}, I_C = 50 \text{ A}$		1.55	2	V
		$V_{GE} = 15 \text{ V}, I_C = 50 \text{ A}, T_J = 125^\circ\text{C}$		1.8		
		$V_{GE} = 15 \text{ V}, I_C = 50 \text{ A}, T_J = 175^\circ\text{C}$		1.9		
$V_{GE(\text{th})}$	Gate threshold voltage	$V_{CE} = V_{GE}, I_C = 1 \text{ mA}$	5	6	7	V
$I_{CES}$	Collector cut-off current	$V_{GE} = 0 \text{ V}, V_{CE} = 650 \text{ V}$			25	$\mu\text{A}$
$I_{GES}$	Gate-emitter leakage current	$V_{CE} = 0 \text{ V}, V_{GE} = \pm 20 \text{ V}$			$\pm 250$	nA

**Table 4. Dynamic characteristics**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{ies}$	Input capacitance	$V_{CE} = 25 \text{ V}, f = 1 \text{ MHz}, V_{GE} = 0 \text{ V}$	-	2928	-	pF
$C_{oes}$	Output capacitance		-	162	-	
$C_{res}$	Reverse transfer capacitance		-	78	-	
$Q_g$	Total gate charge	$V_{CC} = 520 \text{ V}, I_C = 50 \text{ A}, V_{GE} = 0 \text{ to } 15 \text{ V}$ (see Figure 22. Gate charge test circuit)	-	151	-	nC
$Q_{ge}$	Gate-emitter charge		-	30	-	
$Q_{gc}$	Gate-collector charge		-	63	-	

**Table 5. Switching characteristics (inductive load)**

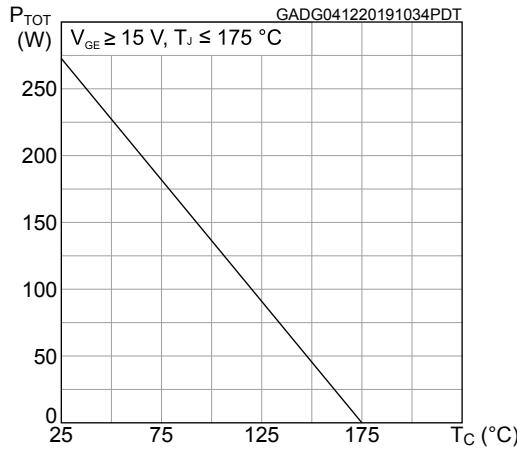
Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	$V_{CC} = 400 \text{ V}, I_C = 50 \text{ A},$ $V_{GE} = 15 \text{ V}, R_G = 4.7 \Omega$ (see Figure 21. Test circuit for inductive load switching)	-	28	-	ns
$t_r$	Current rise time		-	20	-	ns
$E_{on(1)}$	Turn-on switching energy		-	910	-	$\mu\text{J}$
$t_{d(off)}$	Turn-off delay time		-	115	-	ns
$t_f$	Current fall time		-	40	-	ns
$E_{off(2)}$	Turn-off switching energy		-	580	-	$\mu\text{J}$
$t_{d(on)}$	Turn-on delay time		-	24	-	ns
$t_r$	Current rise time		-	17	-	ns
$E_{on(1)}$	Turn-on switching energy	$V_{CC} = 400 \text{ V}, I_C = 50 \text{ A},$ $V_{GE} = 15 \text{ V}, R_G = 4.7 \Omega, T_J = 175^\circ\text{C}$ (see Figure 21. Test circuit for inductive load switching)	-	1800	-	$\mu\text{J}$
$t_{d(off)}$	Turn-off delay time	-	135	-	ns	
$t_f$	Current fall time	-	90	-	ns	
$E_{off(2)}$	Turn-off switching energy	-	1090	-	$\mu\text{J}$	

1. Including the reverse recovery of the external diode. The diode is the same of the co-packed STGWA50H65DFB2.

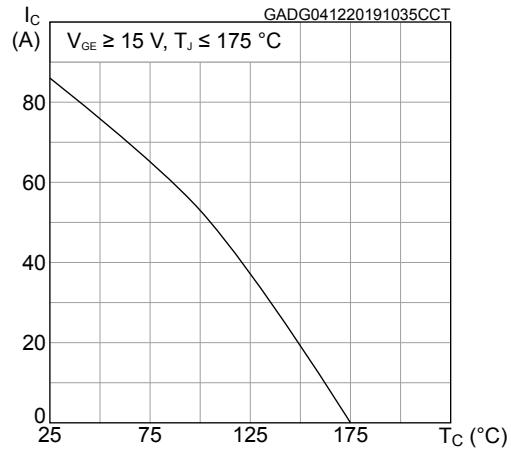
2. Including the tail of the collector current.

## 2.1 Electrical characteristics (curves)

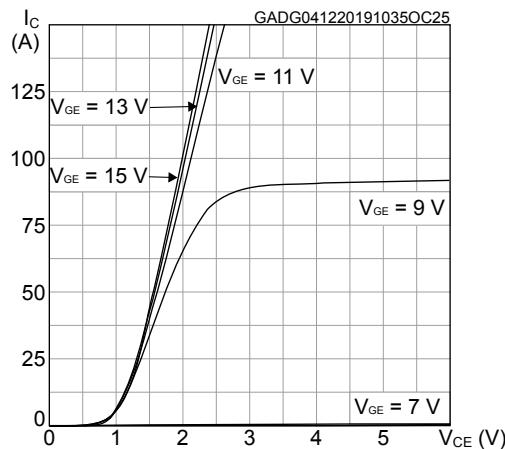
**Figure 1. Power dissipation vs case temperature**



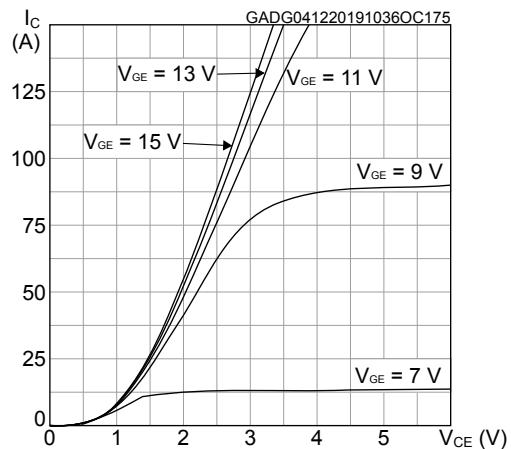
**Figure 2. Collector current vs case temperature**



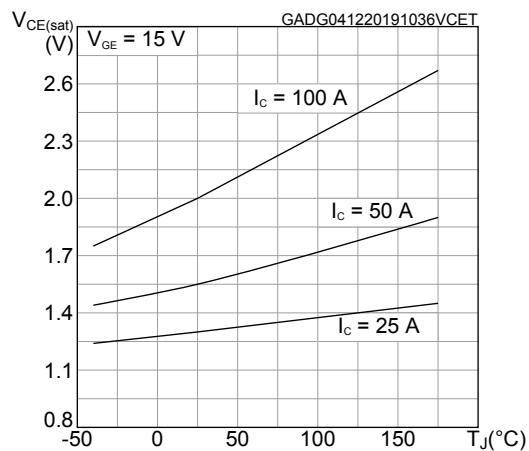
**Figure 3. Output characteristics ( $T_J = 25$  °C)**



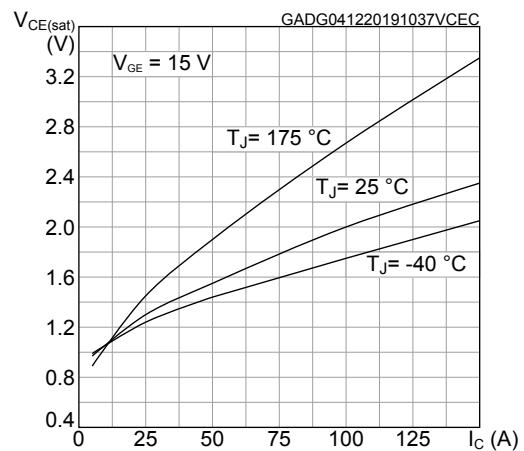
**Figure 4. Output characteristics ( $T_J = 175$  °C)**

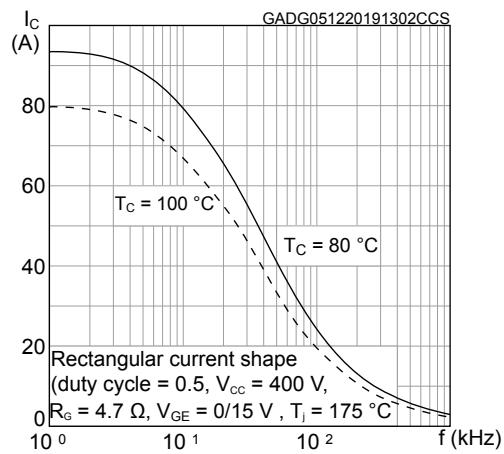
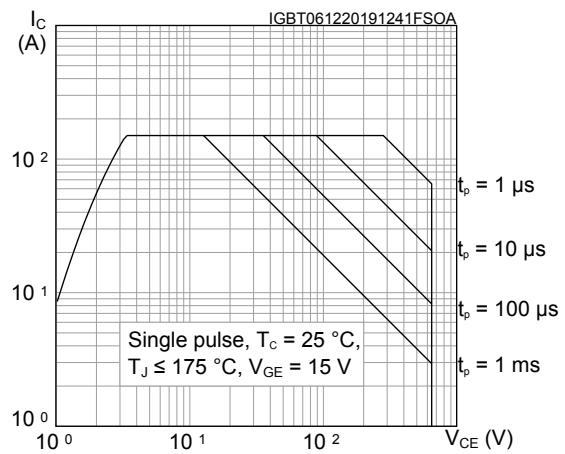
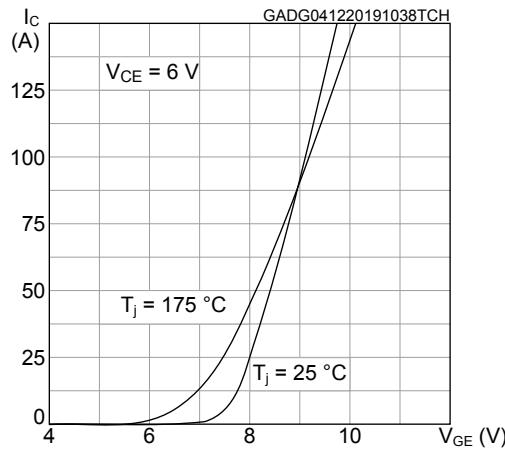
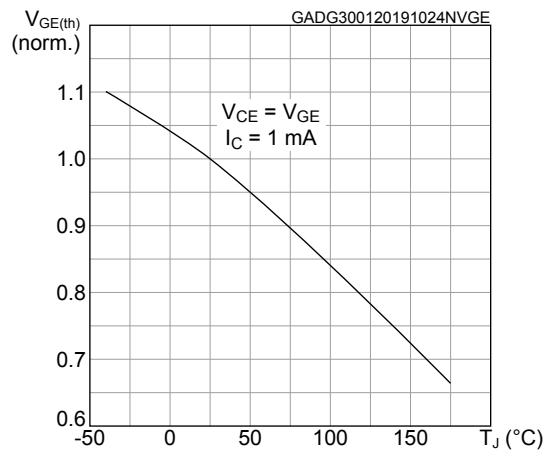
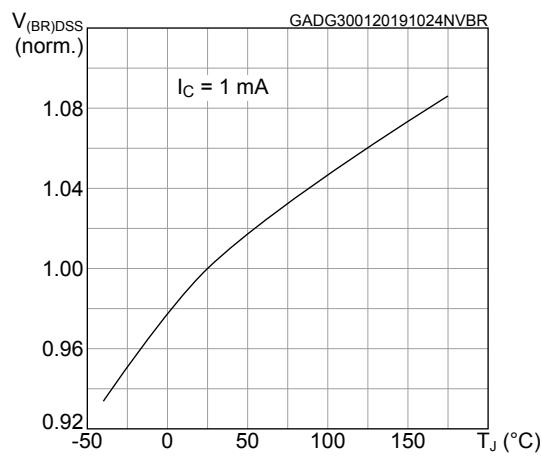
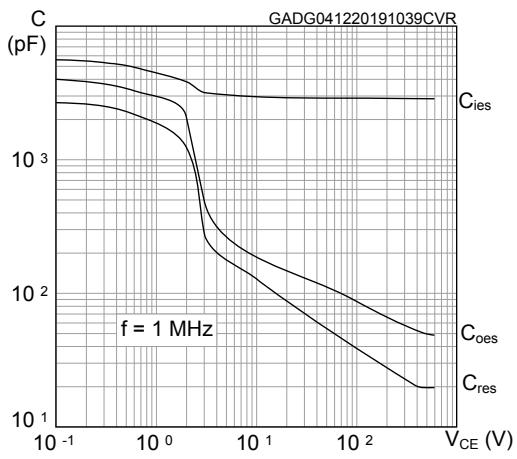


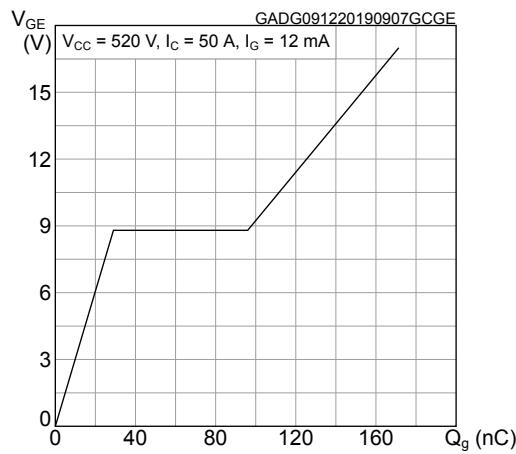
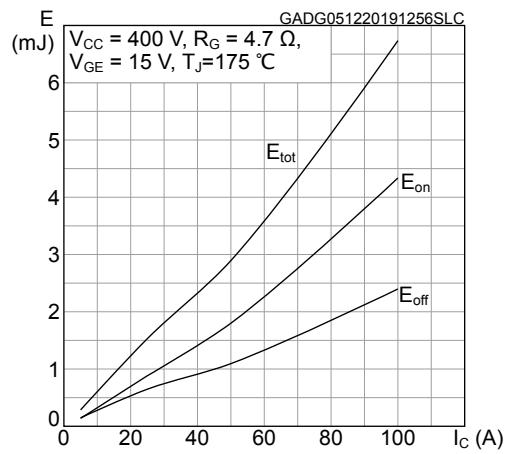
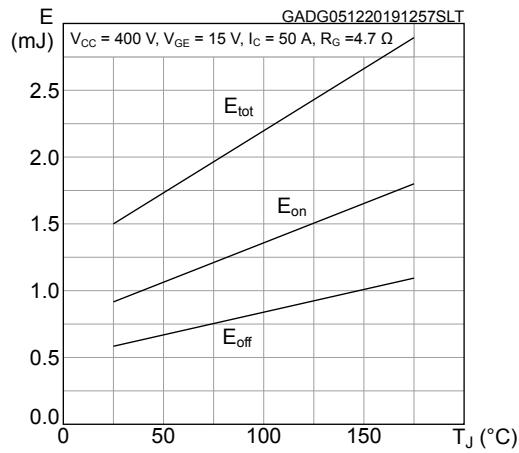
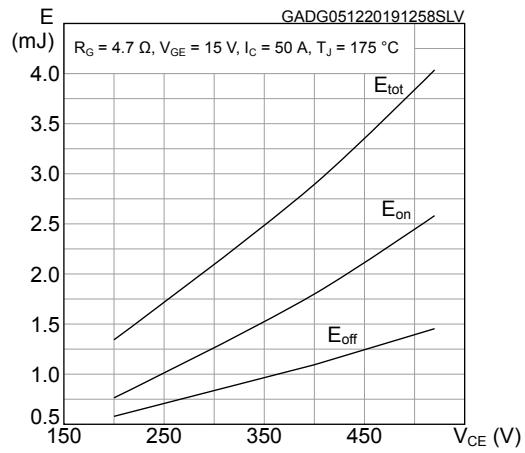
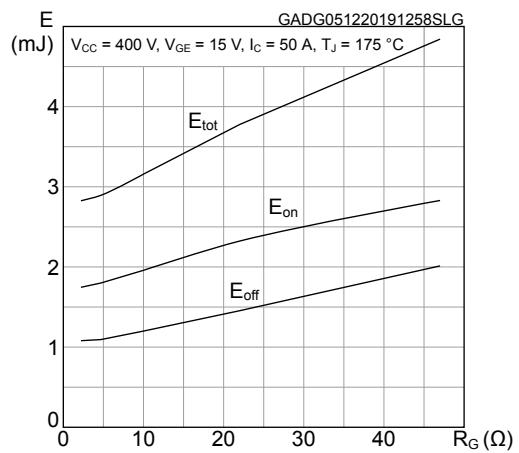
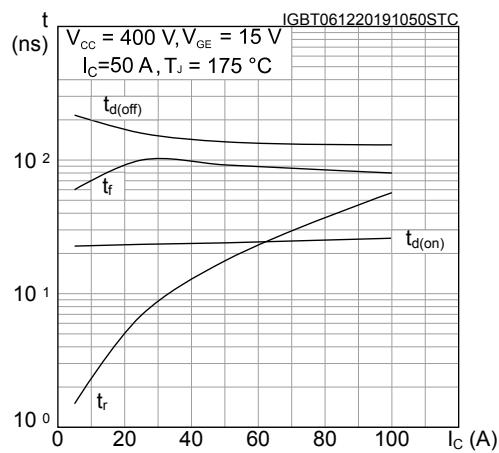
**Figure 5.  $V_{CE(sat)}$  vs junction temperature**

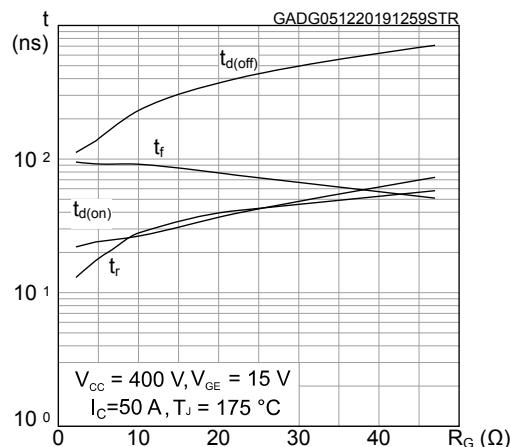
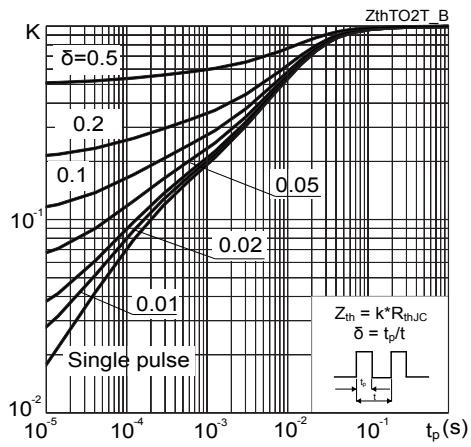


**Figure 6.  $V_{CE(sat)}$  vs collector current**



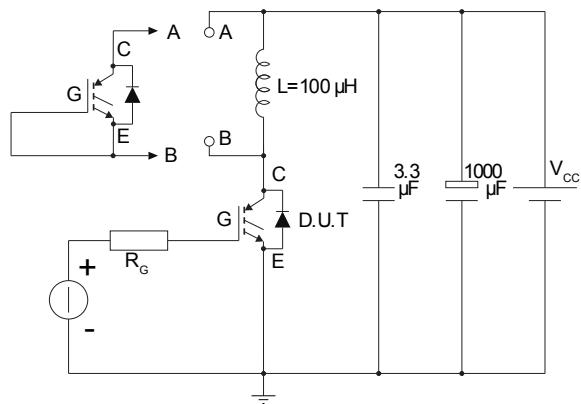
**Figure 7. Collector current vs switching frequency**

**Figure 8. Forward bias safe operating area**

**Figure 9. Transfer characteristics**

**Figure 10. Normalized  $V_{GE(th)}$  vs junction temperature**

**Figure 11. Normalized  $V_{(BR)CES}$  vs junction temperature**

**Figure 12. Capacitance variations**


**Figure 13. Gate charge vs gate-emitter voltage**

**Figure 14. Switching energy vs collector current**

**Figure 15. Switching energy vs temperature**

**Figure 16. Switching energy vs collector emitter voltage**

**Figure 17. Switching energy vs gate resistance**

**Figure 18. Switching times vs collector current**


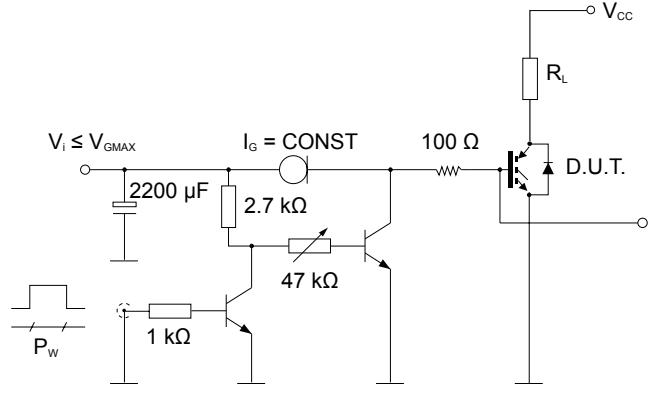
**Figure 19. Switching times vs gate resistance**

**Figure 20. Thermal impedance**


### 3 Test circuits

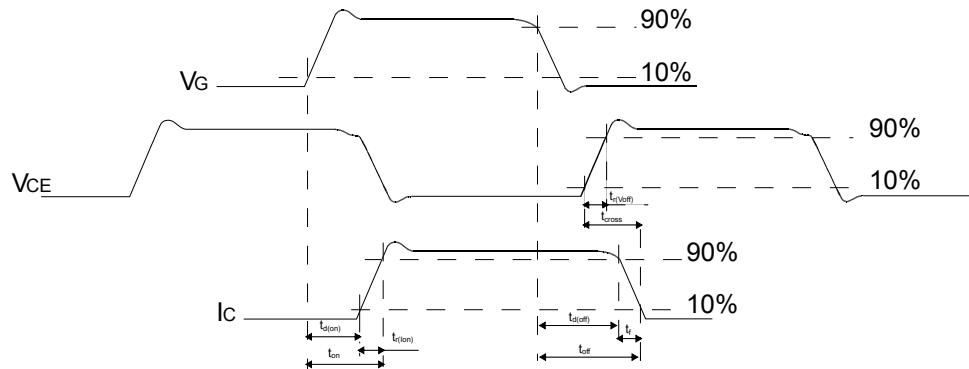
**Figure 21.** Test circuit for inductive load switching



**Figure 22.** Gate charge test circuit



**Figure 23.** Switching waveform



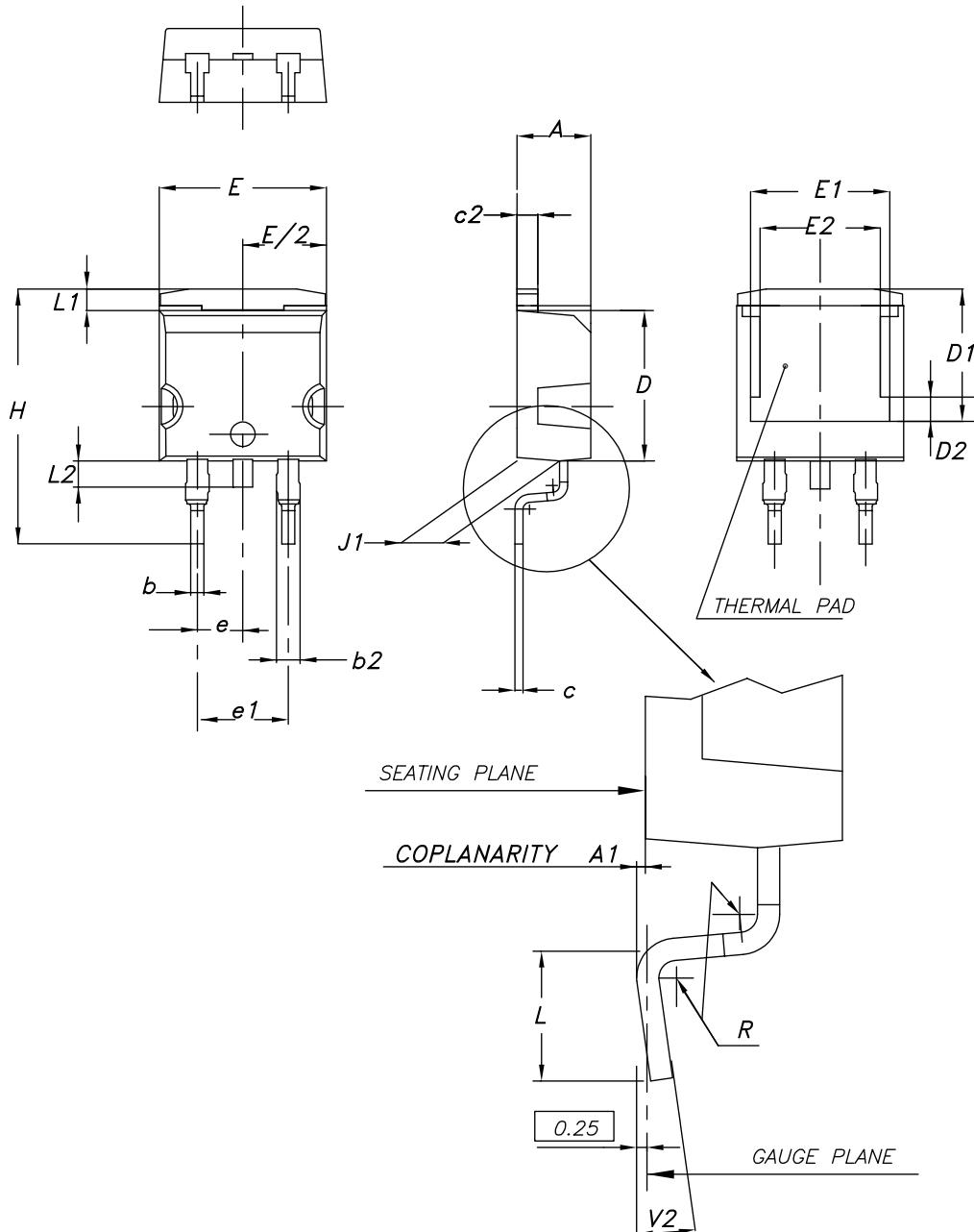
AM01506v1

## 4 Package information

To meet environmental requirements, ST offers these devices in different grades of ECOPACK packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions, and product status are available at: [www.st.com](http://www.st.com). ECOPACK is an ST trademark.

### 4.1 D<sup>2</sup>PAK (TO-263) type A2 package information

Figure 24. D<sup>2</sup>PAK (TO-263) type A2 package outline

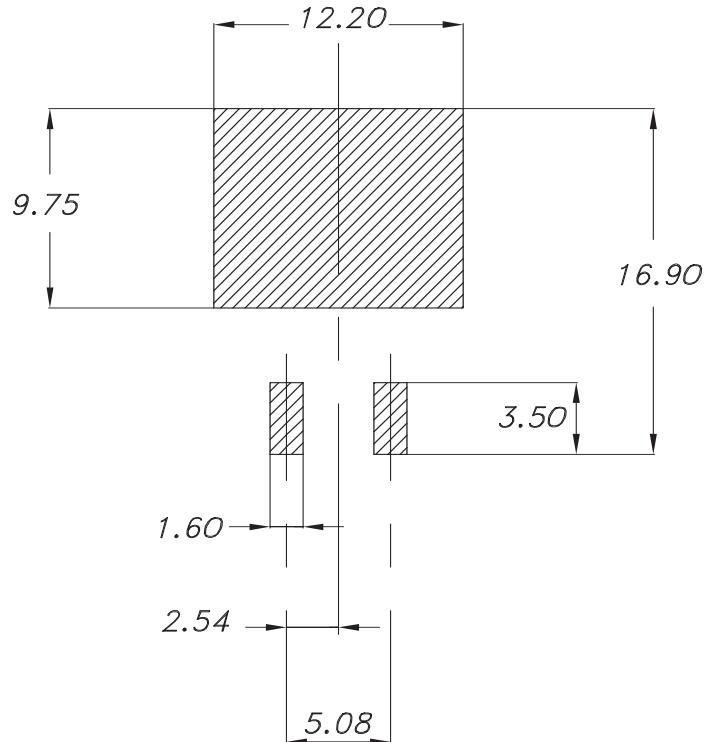


0079457\_A2\_27

**Table 6. D<sup>2</sup>PAK (TO-263) type A2 package mechanical data**

Dim.	mm		
	Min.	Typ.	Max.
A	4.40		4.60
A1	0.03		0.23
b	0.70		0.93
b2	1.14		1.70
c	0.45		0.60
c2	1.23		1.36
D	8.95		9.35
D1	7.50	7.75	8.00
D2	1.10	1.30	1.50
E	10.00		10.40
E1	8.70	8.90	9.10
E2	7.30	7.50	7.70
e		2.54	
e1	4.88		5.28
H	15.00		15.85
J1	2.49		2.69
L	2.29		2.79
L1	1.27		1.40
L2	1.30		1.75
R		0.40	
V2	0°		8°

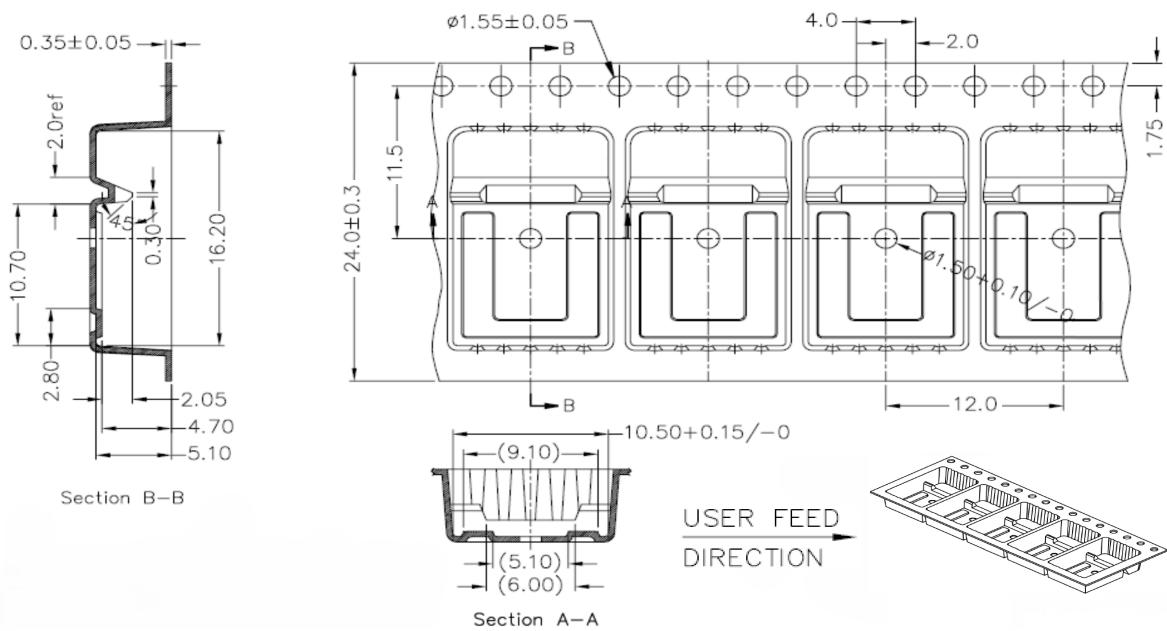
Figure 25. D<sup>2</sup>PAK (TO-263) recommended footprint (dimensions are in mm)



0079457\_Rev27\_footprint

## 4.2 D<sup>2</sup>PAK packing information

Figure 26. D<sup>2</sup>PAK tape drawing (dimensions are in mm)



DM01095771\_1

## Revision history

**Table 7. Document revision history**

Date	Revision	Changes
16-Jan-2020	1	First release.
21-May-2020	2	Updated <i>Section 4 Package information</i> .
05-May-2025	3	Updated <i>Section 4: Package information</i> .

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